

N-Channel JFETs

J/SST/U308 Series

J308 SST308 U309
J309 SST309 U310
J310 SST310

PRODUCT SUMMARY				
Part Number	$V_{GS(off)}$ (V)	$V_{(BR)GSS}$ Min (V)	g_{fs} Min (mS)	I_{DSS} Min (mA)
J308	-1 to -6.5	-25	8	12
J309	-1 to -4	-25	10	12
J310	-2 to -6.5	-25	8	24
SST308	-1 to -6.5	-25	8	12
SST309	-1 to -4	-25	10	12
SST310	-2 to -6.5	-25	8	24
U309	-1 to -4	-25	10	12
U310	-2.5 to -6	-25	10	24

FEATURES

- Excellent High Frequency Gain:
Gps 11.5 dB @ 450 MHz
- Very Low Noise: 2.7 dB @ 450 MHz
- Very Low Distortion
- High ac/dc Switch Off-Isolation

BENEFITS

- Wideband High Gain
- Very High System Sensitivity
- High Quality of Amplification
- High-Speed Switching Capability
- High Low-Level Signal Amplification

APPLICATIONS

- High-Frequency Amplifier/Mixer
- Oscillator
- Sample-and-Hold
- Very Low Capacitance Switches

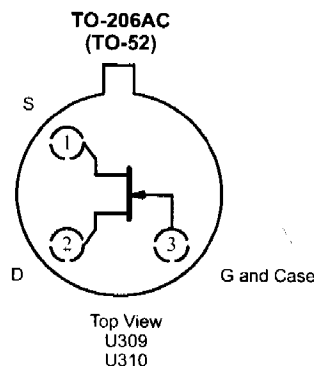
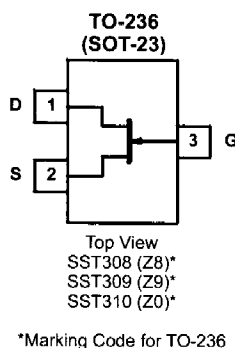
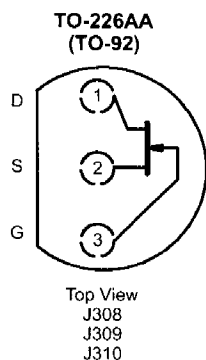
DESCRIPTION

The J/SST/U308 series offers superb amplification characteristics. Of special interest is its high-frequency performance. Even at 450 MHz, this series offers high power gain at low noise.

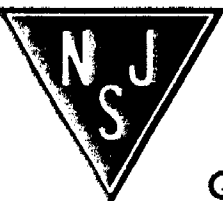
Low-cost J series TO-226AA (TO-92) packaging supports automated assembly with tape-and-reel options. The SST series TO-236 (SOT-23) package provides surface-mount capabilities

and is available with tape-and-reel options. The U series hermetically-sealed TO-206AC (TO-52) package supports full military processing. (See Military and Packaging Information for further details.)

For similar dual products packaged in the TO-78, see the U430/431 data sheet.



NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.



ABSOLUTE MAXIMUM RATINGS

Gate-Drain, Gate-Source Voltage		-25 V
Gate Current :	(J/SST Prefixes)	10 mA
	(U Prefix)	20 mA
Lead Temperature (1/16" from case for 10 sec.)		300°C
Storage Temperature :	(J/SST Prefixes)	-55 to 150°C
	(U Prefix)	-65 to 175°C

Operating Junction Temperature -55 to 150°C

Power Dissipation : (J/SST Prefixes)^a 350 mW
(U Prefix)^b 500 mW

Notes

- a. Derate 2.8 mW/°C above 25°C
b. Derate 4 mW/°C above 25°C

SPECIFICATIONS FOR J/SST308, J/SST309 AND J/SST310 (T_A = 25°C UNLESS NOTED)

Parameter	Symbol	Test Conditions	Typ ^a	Limits						Unit
				J/SST308		J/SST309		J/SST310		
				Min	Max	Min	Max	Min	Max	
Static										
Gate-Source Breakdown Voltage	V _{(BR)GSS}	I _G = -1 μA, V _{DS} = 0 V	-35	-25		-25		-25		V
Gate-Source Cutoff Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 nA		-1	-6.5	-1	-4	-2	-6.5	V
Saturation Drain Current ^b	I _{DSS}	V _{DS} = 10 V, V _{GS} = 0 V		12	60	12	30	24	60	mA
Gate Reverse Current	I _{GSS}	V _{GS} = -15 V, V _{DS} = 0 V	-0.002		-1		-1		-1	nA
		T _A = 125°C	-0.001		-1		-1		-1	μA
Gate Operating Current	I _G	V _{DG} = 9 V, I _D = 10 mA	-15							pA
Drain-Source On-Resistance	r _{DS(on)}	V _{GS} = 0 V, I _D = 1 mA	35							Ω
Gate-Source Forward Voltage	V _{GS(F)}	I _G = 10 mA V _{DS} = 0 V	J	0.7	1		1		1	V
Dynamic										
Common-Source Forward Transconductance	g _{fs}	V _{DS} = 10 V, I _D = 10 mA f = 1 kHz	14	8		10		8		mS
Common-Source Output Conductance	g _{os}		110		250		250		250	μS
Common-Source Input Capacitance	C _{iss}	V _{DS} = 10 V V _{GS} = -10 V f = 1 MHz	J	4	5		5		5	pF
Common-Source Reverse Transfer Capacitance	C _{rss}		SST	4						
			J	1.9	2.5		2.5		2.5	
			SST	1.9						
Equivalent Input Noise Voltage	e _n	V _{DS} = 10 V, I _D = 10 mA f = 100 Hz	6							nV/ √Hz
High Frequency										
Common-Gate Forward Transconductance	g _{fg}	V _{DS} = 10 V I _D = 10 mA	f = 105 MHz	14						mS
Common-Gate Output Conductance	g _{og}		f = 450 MHz	13						
			f = 105 MHz	0.16						
			f = 450 MHz	0.55						
Common-Gate Power Gain ^c	G _{pg}		f = 105 MHz	16						dB
			f = 450 MHz	11.5						
			f = 105 MHz	1.5						
Noise Figure	NF		f = 450 MHz	2.7						

Notes

- a. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
b. Pulse test: PW ≤ 300 μs duty cycle ≤ 3%.
c. Gain (G_{pg}) measured at optimum input noise match.

SPECIFICATIONS FOR U309 AND U310 ($T_A = 25^\circ\text{C}$ UNLESS NOTED)

Parameter	Symbol	Test Conditions	Typ ^a	Limits				Unit	
				U309		U310			
				Min	Max	Min	Max		
Static									
Gate-Source Breakdown Voltage	V _{(BR)GSS}	I _G = -1 μA , V _{DS} = 0 V	-35	-25		-25		V	
Gate-Source Cutoff Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 nA		-1	-4	-2.5	-6	V	
Saturation Drain Current ^b	I _{DSS}	V _{DS} = 10 V, V _{GS} = 0 V		12	30	24	60	mA	
Gate Reverse Current	I _{GSS}	V _{GS} = -15 V, V _{DS} = 0 V	-0.002		-0.15		-0.15	nA	
		T _A = 125°C	-0.001		-0.15		-0.15	μA	
Gate Operating Current	I _G	V _{DG} = 9 V, I _D = 10 mA	-15					pA	
Drain-Source On-Resistance	r _{DS(on)}	V _{GS} = 0 V, I _D = 1 mA	35					Ω	
Gate-Source Forward Voltage	V _{GS(F)}	I _G = 10 mA , V _{DS} = 0 V	0.7		1		1	V	
Dynamic									
Common-Source Forward Transconductance	g _{fs}	V _{DS} = 10 V, I _D = 10 mA f = 1 kHz	14	10		10		mS	
Common-Source Output Conductance	g _{os}		110		250		250	μS	
Common-Source Input Capacitance	C _{iss}	V _{DS} = 10 V, V _{GS} = -10 V f = 1 MHz	4		5		5	pF	
Common-Source Reverse Transfer Capacitance	C _{rss}		1.9		2.5		2.5		
Equivalent Input Noise Voltage	e _n	V _{DS} = 10 V, I _D = 10 mA f = 100 Hz	6					nV/ √Hz	
High Frequency									
Common-Gate Forward Transconductance	g _{fg}	V _{DS} = 10 V I _D = 10 mA	f = 105 MHz	14				mS	
			f = 450 MHz	13					
Common-Gate Output Conductance	g _{og}		f = 105 MHz	0.16					
			f = 450 MHz	0.55					
Common-Gate Power Gain ^c	G _{pg}		f = 105 MHz	16	14		14	dB	
			f = 450 MHz	11.5	10		10		
Noise Figure	NF		f = 105 MHz	1.5		2	2		
			f = 450 MHz	2.7		3.5	3.5		

Notes

- a. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
b. Pulse test: $PW \leq 300\ \mu\text{s}$ duty cycle $\leq 3\%$.
c. Gain (G_{pg}) measured at optimum input noise match.